

## Features

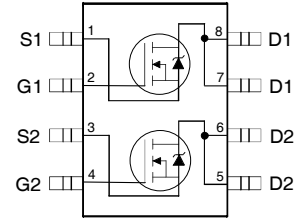
- $V_{DS} (V) = 60V$
- $I_D = 8A (V_{GS}=10V)$
- $R_{DS(ON)} < 23 m\Omega (V_{GS} = 10V)$

## Applications

- Synchronous Rectifier MOSFET for Isolated DC-DC Converters
- Low Power Motor Drive Systems

## Benefits

- Ultra-Low Gate Impedance
- Fully Characterized Avalanche Voltage and Current
- 20V  $V_{GS}$  Max. Gate Rating



SOP-8

## Absolute Maximum Ratings

	Parameter	Max.	Units
$V_{DS}$	Drain-to-Source Voltage	60	V
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	
$I_D @ T_A = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	8.0	A
$I_D @ T_A = 70^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	6.4	
$I_{DM}$	Pulsed Drain Current ①	64	
$P_D @ T_A = 25^\circ C$	Power Dissipation ④	2.0	W
$P_D @ T_A = 70^\circ C$	Power Dissipation ④	1.28	
	Linear Derating Factor	0.016	W/°C
$T_J$	Operating Junction and	-55 to + 150	°C
$T_{STG}$	Storage Temperature Range		

## Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JL}$	Junction-to-Drain Lead ⑤		20	°C/W
$R_{\theta JA}$	Junction-to-Ambient ④⑤		62.5	

### Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	60			V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA
ΔBV <sub>DSS</sub> /ΔT <sub>J</sub>	Breakdown Voltage Temp. Coefficient		0.068		V/°C	Reference to 25°C, I <sub>D</sub> = 1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		13.7	23	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 8.0A ③
V <sub>GS(th)</sub>	Gate Threshold Voltage			2	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 50μA
ΔV <sub>GS(th)</sub>	Gate Threshold Voltage Coefficient		-8.2		mV/°C	
I <sub>DSS</sub>	Drain-to-Source Leakage Current			20	μA	V <sub>DS</sub> = 60V, V <sub>GS</sub> = 0V
				250		V <sub>DS</sub> = 60V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 125°C
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	nA	V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage			-100		V <sub>GS</sub> = -20V
g <sub>fs</sub>	Forward Transconductance	18			S	V <sub>DS</sub> = 25V, I <sub>D</sub> = 6.4A
Q <sub>g</sub>	Total Gate Charge		24	36	nC	V <sub>DS</sub> = 30V V <sub>GS</sub> = 10V I <sub>D</sub> = 6.4A See Fig. 17
Q <sub>gs1</sub>	Pre-V <sub>th</sub> Gate-to-Source Charge		3.8			
Q <sub>gs2</sub>	Post-V <sub>th</sub> Gate-to-Source Charge		1.2			
Q <sub>gd</sub>	Gate-to-Drain Charge		7.2			
Q <sub>godr</sub>	Gate Charge Overdrive		11.8			
Q <sub>sw</sub>	Switch Charge (Q <sub>gs2</sub> + Q <sub>gd</sub> )		8.4			
Q <sub>oss</sub>	Output Charge		7.5			
t <sub>d(on)</sub>	Turn-On Delay Time		5.1		ns	V <sub>DD</sub> = 30V, V <sub>GS</sub> = 10V ③ I <sub>D</sub> = 6.4A R <sub>G</sub> = 1.8Ω
t <sub>r</sub>	Rise Time		5.9			
t <sub>d(off)</sub>	Turn-Off Delay Time		17			
t <sub>f</sub>	Fall Time		6.7			
C <sub>iss</sub>	Input Capacitance		1330		pF	V <sub>GS</sub> = 0V V <sub>DS</sub> = 30V f = 1.0MHz
C <sub>oss</sub>	Output Capacitance		190			
C <sub>rss</sub>	Reverse Transfer Capacitance		92			

### Avalanche Characteristics

	Parameter	Typ.	Max.	Units
E <sub>AS</sub>	Single Pulse Avalanche Energy ②		325	mJ
I <sub>AR</sub>	Avalanche Current ①		6.4	A

### Diode Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)			1.8	A	MOSFET symbol showing the integral reverse p-n junction diode.
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①			64		
V <sub>SD</sub>	Diode Forward Voltage			1.3	V	T <sub>J</sub> = 25°C, I <sub>S</sub> = 6.4A, V <sub>GS</sub> = 0V ③
t <sub>rr</sub>	Reverse Recovery Time		20	30	ns	T <sub>J</sub> = 25°C, I <sub>F</sub> = 6.4A, V <sub>DD</sub> = 30V
Q <sub>rr</sub>	Reverse Recovery Charge		61	92	nC	di/dt = 300A/μs ③

#### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting T<sub>J</sub> = 25°C, L = 16mH  
R<sub>G</sub> = 25Ω, I<sub>AS</sub> = 6.4A.
- ③ Pulse width ≤ 400μs; duty cycle ≤ 2%.
- ④ When mounted on 1 inch square copper board.
- ⑤ R<sub>θ</sub> is measured at T<sub>J</sub> approximately 90°C.

### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

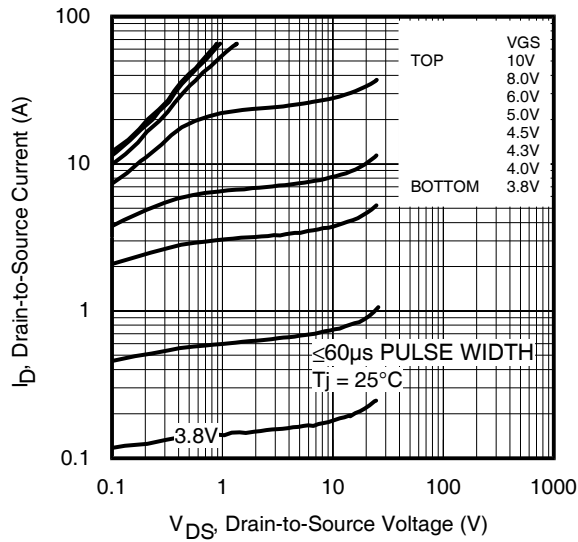


Fig 1. Typical Output Characteristics

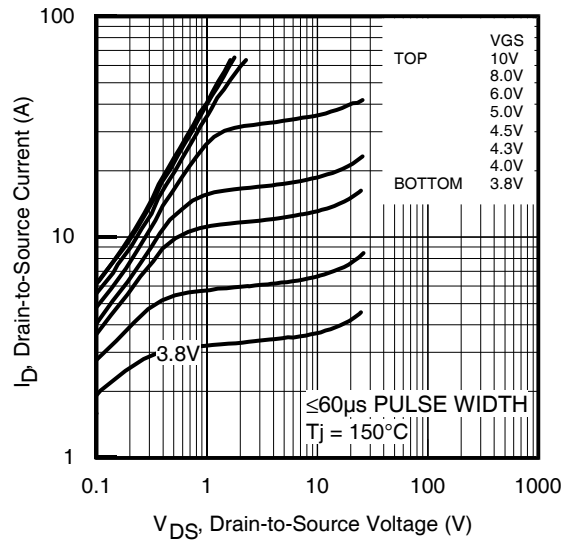


Fig 2. Typical Output Characteristics

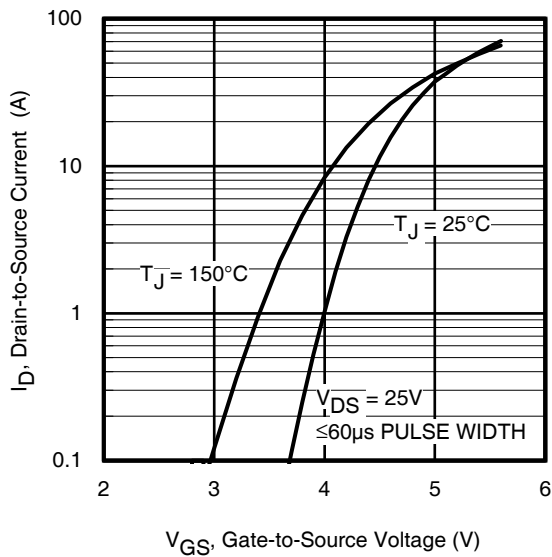


Fig 3. Typical Transfer Characteristics

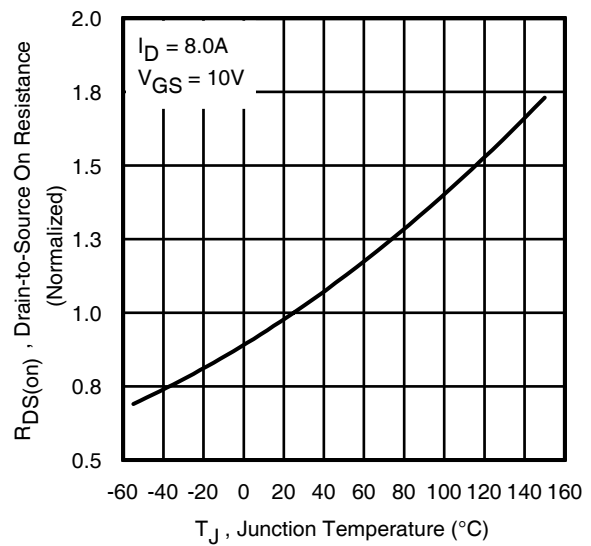
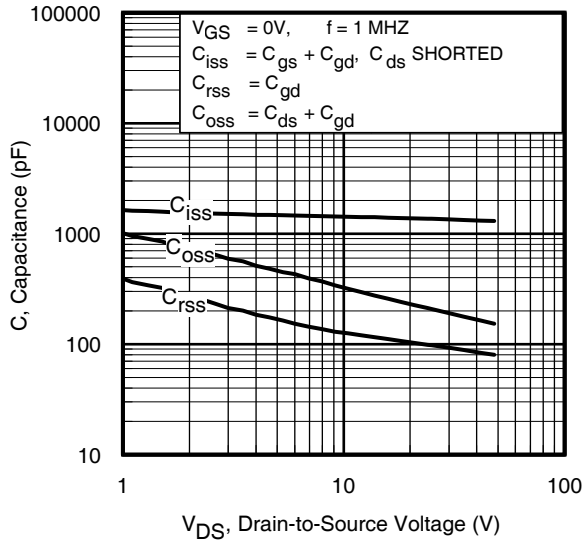
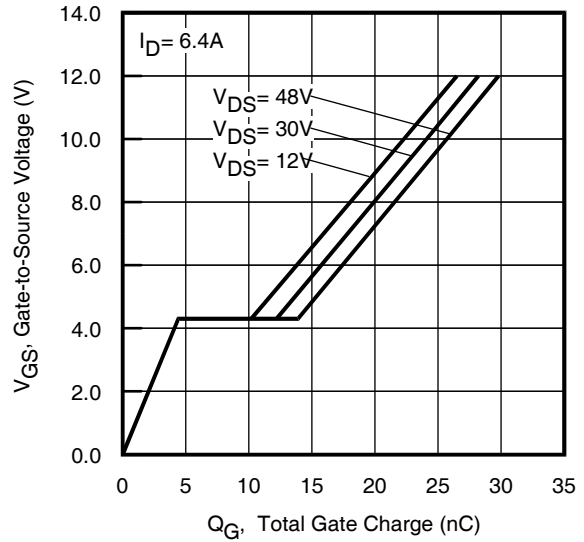


Fig 4. Normalized On-Resistance vs. Temperature

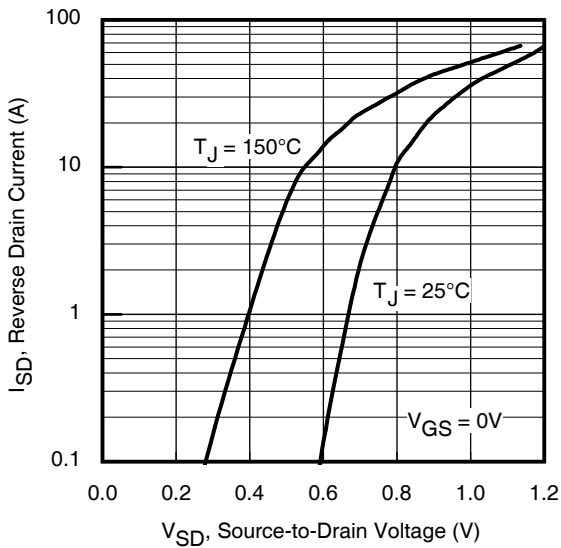
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)



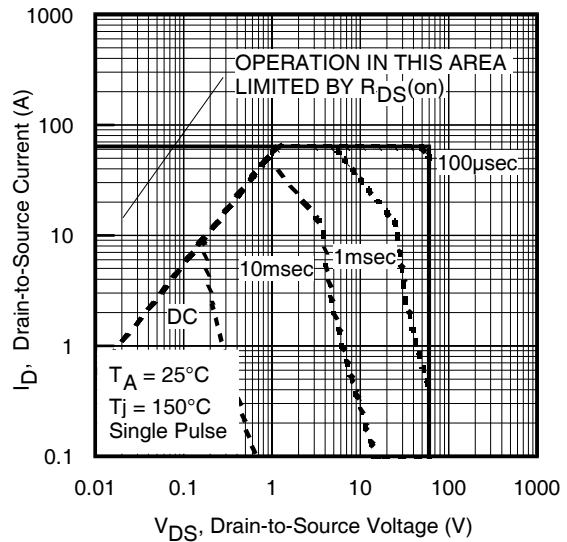
**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage



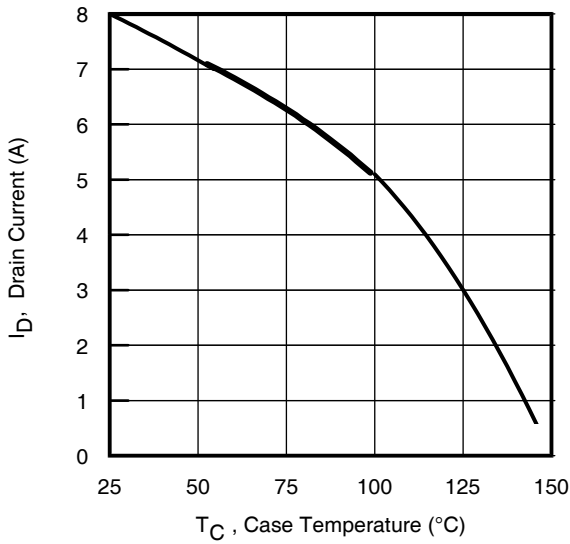
**Fig 6.** Typical Gate Charge vs. Gate-to-Source Voltage



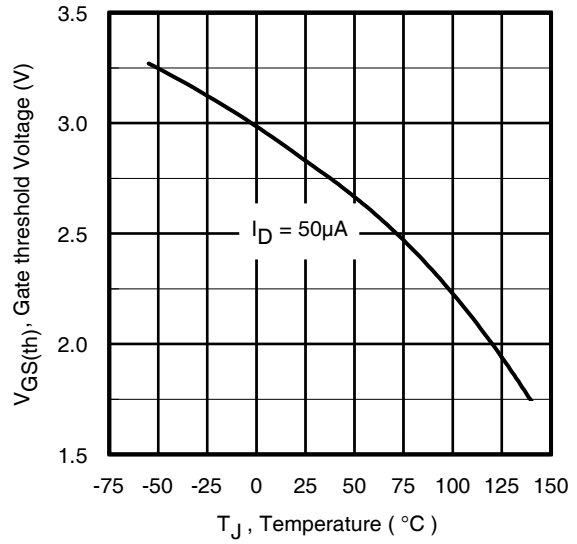
**Fig 7.** Typical Source-Drain Diode Forward Voltage



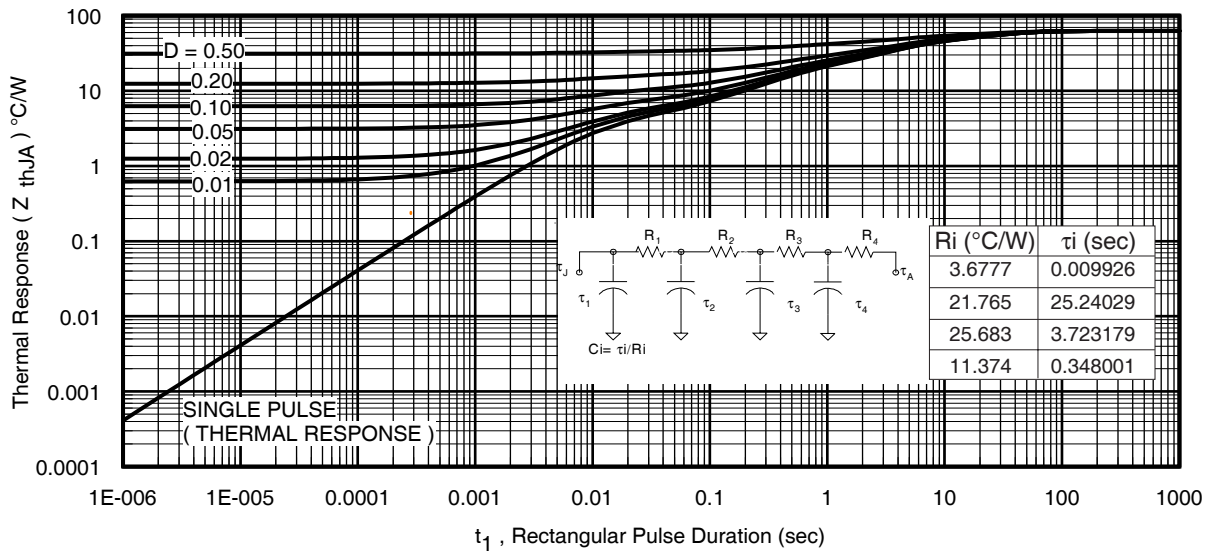
**Fig 8.** Maximum Safe Operating Area



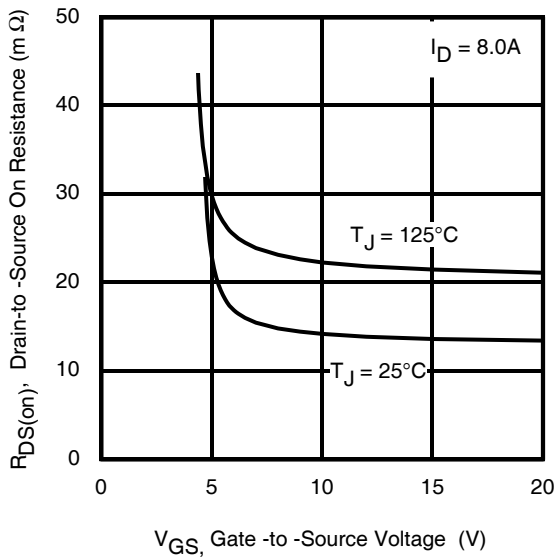
**Fig 9.** Maximum Drain Current vs. Case Temperature



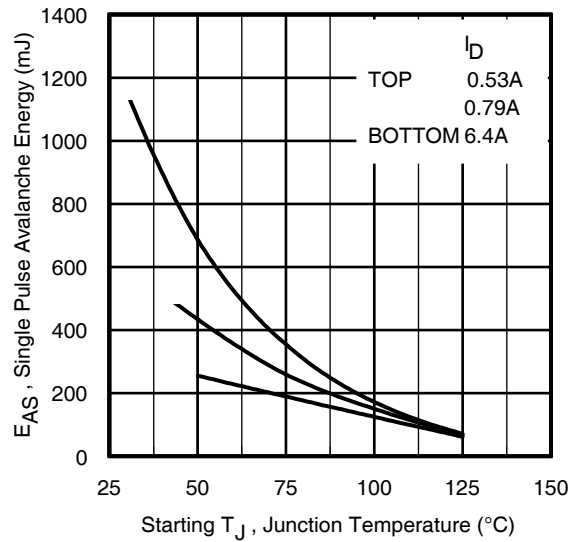
**Fig 10.** Threshold Voltage vs. Temperature



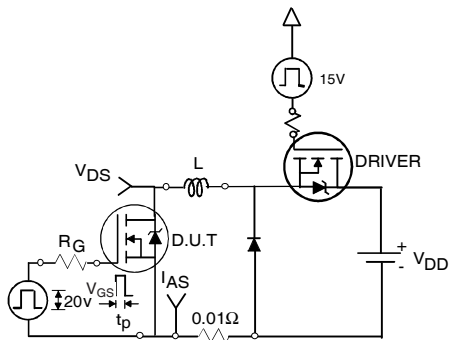
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



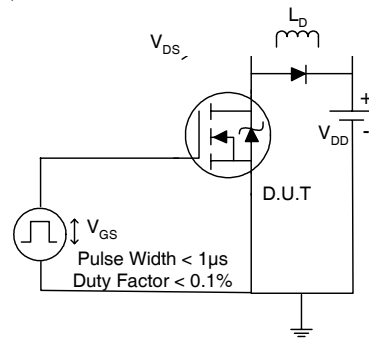
**Fig 12.** On-Resistance vs. Gate Voltage



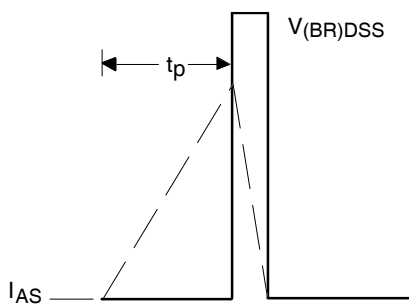
**Fig 13.** Maximum Avalanche Energy vs. Drain Current



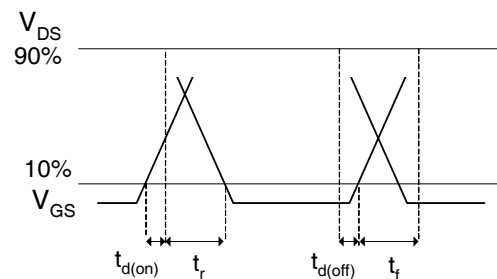
**Fig 14a.** Unclamped Inductive Test Circuit



**Fig 15a.** Switching Time Test Circuit



**Fig 14b.** Unclamped Inductive Waveforms



**Fig 15b.** Switching Time Waveforms

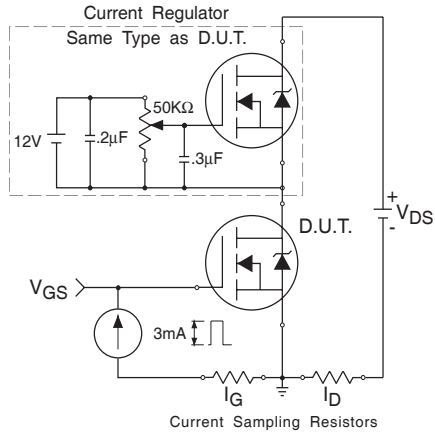


Fig 17a. Gate Charge Test Circuit

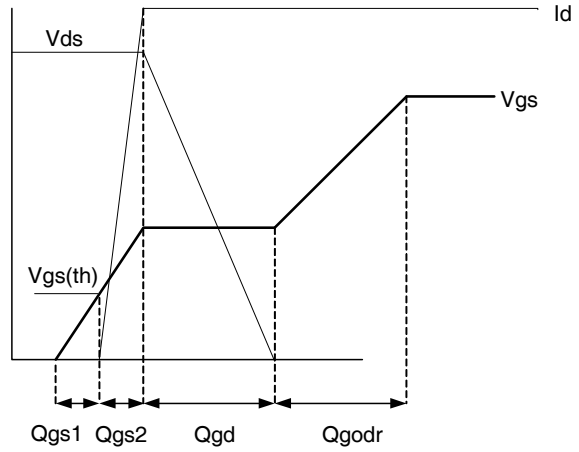
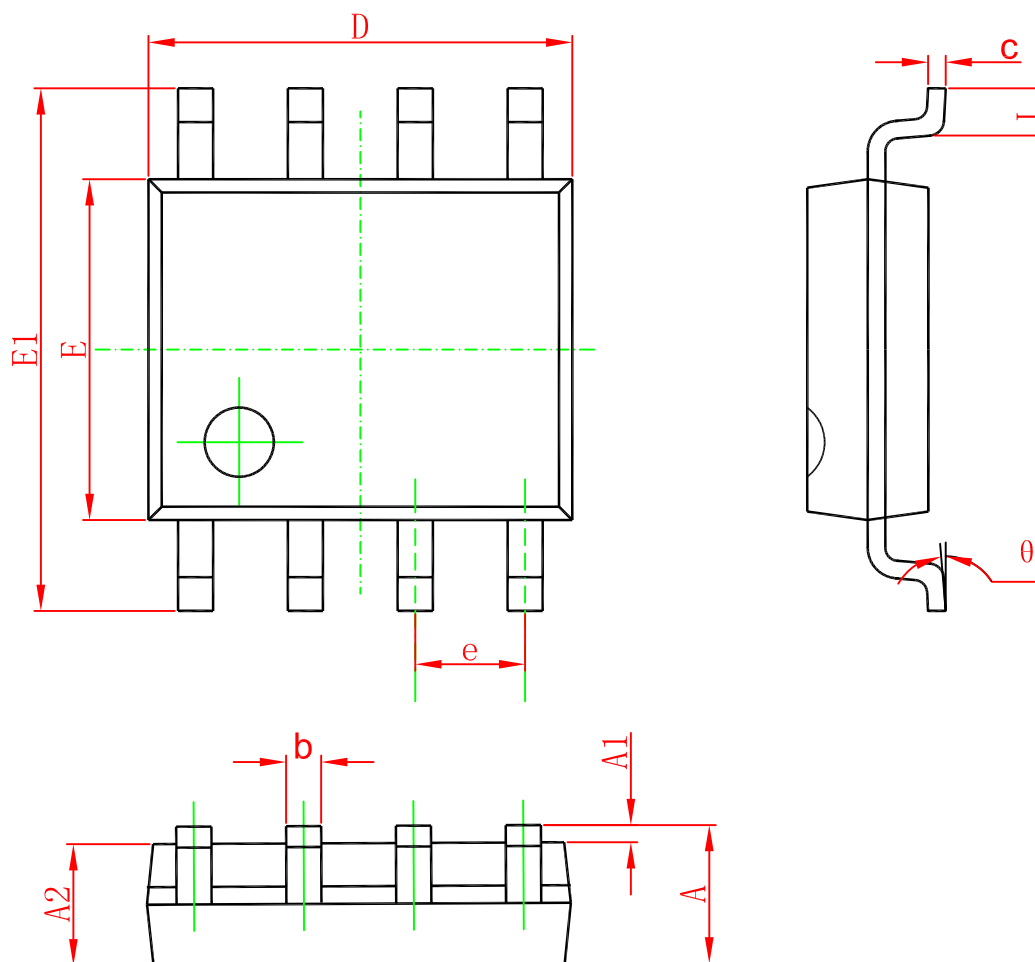


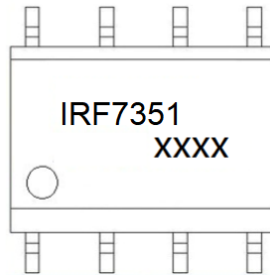
Fig 17b. Gate Charge Waveform

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Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270(BSC)		0.050(BSC)	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°



**Marking****Ordering information**

Order code	Package	Baseqty	Deliverymode
IRF7351TR	SOP-8	3000	Tape and reel